

Silicon Carbide Junction Transistor/Schottky Diode Co-pack

Features

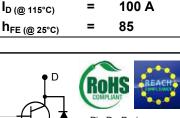
- 175 °C Maximum Operating Temperature
- Gate Oxide Free SiC Switch
- Optional Gate Return Pin
- Exceptional Safe Operating Area
- Integrated SiC Schottky Rectifier
- Excellent Gain Linearity
- Temperature Independent Switching Performance
- · Low Output Capacitance
- Positive Temperature Coefficient of R_{DS,ON}
- Suitable for Connecting an Anti-parallel Diode

Advantages

- Compatible with Si MOSFET/IGBT Gate Drive ICs
- > 20 µs Short-Circuit Withstand Capability
- Lowest-in-class Conduction Losses
- High Circuit Efficiency
- Minimal Input Signal Distortion
- High Amplifier Bandwidth
- · Reduced cooling requirements
- Reduced system size

Package





Pin D - Drain Pin S - Source Pin GR - Gate Return Pin G - Gate

1200 V

10 mΩ

160 A

100 A

Isolated Baseplate SOT-227

Please note: The Source and Gate Return pins are not exchangeable. Their exchange might lead to malfunction.

9

Applications

• Down Hole Oil Drilling, Geothermal Instrumentation

G

GR

 V_{DS}

R_{DS(ON)}

I_{D (@ 25°C)}

- Hybrid Electric Vehicles (HEV)
- Solar Inverters
- Switched-Mode Power Supply (SMPS)
- Power Factor Correction (PFC)
- Induction Heating
- Uninterruptible Power Supply (UPS)
- Motor Drives

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Section I: Absolute Maximum Ratings

Parameter	Symbol	Conditions	Value	Unit	Notes
SiC Junction Transistor					
Drain – Source Voltage	V _{DS}	$V_{GS} = 0 V$	1200	V	
Continuous Drain Current	I _D	$T_{\rm C}$ = 25°C	160	А	Fig. 17
Continuous Drain Current	ID	T _c = 115°C	100	А	Fig. 17
Continuous Gate Current	I _G		7	А	
Continuous Gate Return Current	I _{GR}		7		
Turn-Off Safe Operating Area	RBSOA	T _{VJ} = 175 ^o C, Clamped Inductive Load	I _{D,max} = 100 @ V _{DS} ≤ V _{DSmax}	А	Fig. 19
Short Circuit Safe Operating Area	SCSOA	T_{VJ} = 175 °C, I_G = 1 A, V_{DS} = 800 V, Non Repetitive	>20	μs	
Reverse Gate – Source Voltage	V _{SG}		30	V	
Reverse Drain – Source Voltage	V _{SD}		25	V	
Power Dissipation	P _{tot}	T_{C} = 25 °C / 115 °C, t_{p} > 100 ms	535 / 214	W	Fig. 16
Operating and storage temperature	T _{stg}		-55 to 175	°C	

GA100SICP12-227

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Parameter	Symbol	Conditions	Value	Unit	Notes
Free-Wheeling SiC Diode					
Repetitive peak reverse voltage	V _{RRM}		1200	V	
Continuous forward current	I _F	T _C ≤ 135 °C	100	А	
RMS forward current	I _{F(RMS)}	T _C ≤ 135 °C	174	А	
Surge non-repetitive forward current, Half Sine Wave	I _{F,SM}	T_{C} = 25 °C, t_{P} = 10 ms T_{C} = 135 °C, t_{P} = 10 ms	700 626	А	
Non-repetitive peak forward current	I _{F,max}	$T_{\rm C}$ = 25 °C, $t_{\rm P}$ = 10 µs	3250	А	
l ² t value	∫i² dt	T_{C} = 25 °C, t _P = 10 ms T_{C} = 135 °C, t _P = 10 ms	900 600	A ² s	
Thermal Characteristics					
Thermal resistance, junction - case	R _{thJC}	SiC Junction Transistor	0.28	°C/W	Fig. 20
Thermal resistance, junction - case	R _{thJC}	SiC Diode	0.26	°C/W	Fig. 21

Section II: Static Electrical Characteristics

Devemeter	Symphol	Conditions	Value			11	Natas
Parameter	Symbol Conditions		Min.	Typical	Max.	Unit	Notes
A: On State							
Drain – Source On Resistance	R _{DS(ON)}	$\begin{array}{l} I_{\rm D} = 100 \mbox{ A}, \mbox{ T}_{\rm j} = 25 \ ^{\circ}{\rm C} \\ I_{\rm D} = 100 \mbox{ A}, \mbox{ T}_{\rm j} = 150 \ ^{\circ}{\rm C} \\ I_{\rm D} = 100 \mbox{ A}, \mbox{ T}_{\rm j} = 175 \ ^{\circ}{\rm C} \end{array}$		10 15 18		mΩ	Fig. 5
Gate – Source Saturation Voltage	$V_{GS,SAT}$	$I_D = 100 \text{ A}, I_D/I_G = 40, T_j = 25 \text{ °C}$ $I_D = 100 \text{ A}, I_D/I_G = 30, T_j = 175 \text{ °C}$		3.42 3.23		V	Fig. 7
DC Current Gain h_{FE} $V_{DS} = V_{DS}$				85 57 51		_	Fig. 4
FWD forward voltage	V_{F}	I _F = 100 A, T _j = 25 °C I _F = 100 A, T _j = 175 °C		1.4 2.1	1.8 3.0	V	
B: Off State							
Drain Leakage Current	I _{DSS}	$ \begin{array}{l} V_{DS} = 1200 \; V, \; V_{GS} = 0 \; V, \; T_{j} = 25 \; ^{\circ}\text{C} \\ V_{DS} = 1200 \; V, \; V_{GS} = 0 \; V, \; T_{j} = 150 \; ^{\circ}\text{C} \\ V_{DS} = 1200 \; V, \; V_{GS} = 0 \; V, \; T_{j} = 175 \; ^{\circ}\text{C} \end{array} $		100 300 600		μA	Fig. 8
Gate Leakage Current	I _{SG}	V _{SG} = 20 V, T _i = 25 °C		40		nA	

Section III: Dynamic Electrical Characteristics

Parameter	Symbol	Symbol Conditions -		Value		- Unit	Notes
Parameter	Symbol			Typical Max.			
A: Capacitance and Gate Charge	9						
Input Capacitance	C _{iss}	V _{GS} = 0 V, V _{DS} = 800 V, <i>f</i> = 1 MHz		16.1		nF	Fig. 9
Reverse Transfer/Output Capacitance	C_{rss}/C_{oss}	V _{DS} = 1 V, f = 1 MHz V _{DS} = 400 V, f = 1 MHz V _{DS} = 800 V, <i>f</i> = 1 MHz		6480 570 440		pF	Fig. 9
Total Output Capacitance Charge	Q _{oss}	V _{DS} = 400 V V _{DS} = 800 V		375 570		nC	
Output Capacitance Stored Energy	Eoss	V _{GS} = 0 V, V _{DS} = 800 V, <i>f</i> = 1 MHz		170		μJ	Fig. 10
Effective Output Capacitance, time related	$C_{\text{oss,tr}}$	I_{D} = constant, V_{GS} = 0 V, V_{DS} = 0…800 V		715		pF	
Effective Output Capacitance, energy related	$C_{\text{oss,er}}$	V_{GS} = 0 V, V_{DS} = 0800 V		535		pF	
Gate-Source Charge	Q_{GS}	V _{GS} = -53 V		130		nC	
Gate-Drain Charge	Q_{GD}	V _{GS} = 0 V, V _{DS} = 0800 V		570		nC	
Gate Charge - Total	Q_{G}			700		nC	



Devemeter	Cum hal	Conditions	Value			11	Natas	
Parameter	Symbol	Conditions	Min.	Typical Max.		Unit	Notes	
B: SJT Switching ¹								
Internal Gate Resistance – ON	R _{G(INT-ON)}	V _{GS} > 2.5 V, V _{DS} = 0 V, T _j = 175 °C		0.1		Ω		
Turn On Delay Time	t _{d(on)}	$T_i = 25 \text{ °C}, V_{DS} = 800 \text{ V},$		12		ns		
Fall Time, V _{DS}	t _f	I _D = 50 A, Resistive Load Refer to Section V for additional		40		ns	Fig. 11, 13	
Turn Off Delay Time	$t_{d(off)}$			37		ns		
Rise Time, V _{DS}	tr	driving information.		25		ns	Fig. 12, 14	
Turn On Delay Time	t _{d(on)}			10		ns		
Fall Time, V _{DS}	t _f	T _j = 175 °C, V _{DS} = 800 V, I _D = 50 A, Resistive Load		40		ns	Fig. 11	
Turn Off Delay Time	t _{d(off)}			45		ns		
Rise Time, V _{DS}	t _r	-		20		ns	Fig. 12	
Turn-On Energy Per Pulse	Eon	T _i = 25 °C, V _{DS} = 800 V,		1.8		mJ	Fig. 11, 13	
Turn-Off Energy Per Pulse	E _{off}	$I_D = 50 \text{ A}$, Inductive Load		1.4		mJ	Fig. 12, 14	
Total Switching Energy	E _{tot}	Refer to Section V.		3.2		mJ		
Turn-On Energy Per Pulse				1.85		mJ	Fig. 11	
Turn-Off Energy Per Pulse	E _{off}	$- T_{j} = 175 \text{ °C}, V_{DS} = 800 \text{ V}, $ - I_D = 50 A, Inductive Load		1.3		mJ	Fig. 12	
Total Switching Energy	E _{tot}			3.15		mJ		

 1 – All times are relative to the Drain-Source Voltage V_{DS}

GA100SICP12-227

Section IV: Figures



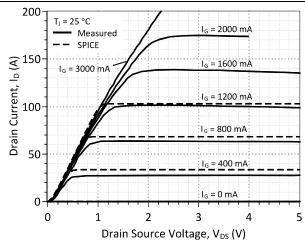


Figure 1: Typical Output Characteristics at 25 °C

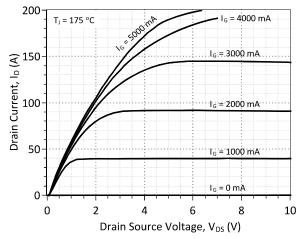


Figure 3: Typical Output Characteristics at 175 °C

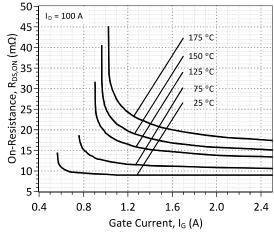


Figure 5: On-Resistance vs. Gate Current

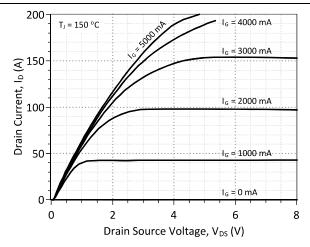


Figure 2: Typical Output Characteristics at 150 °C

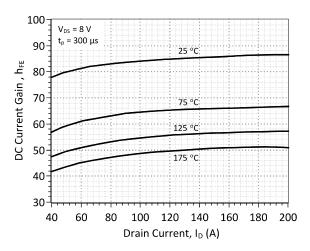


Figure 4: DC Current Gain vs. Drain Current

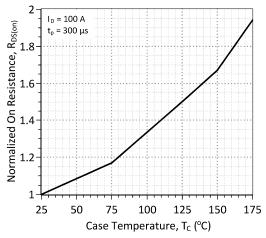
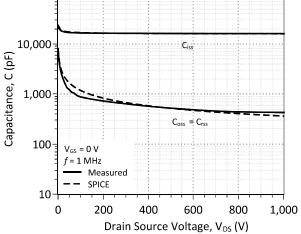


Figure 6: Normalized On-Resistance vs. Temperature

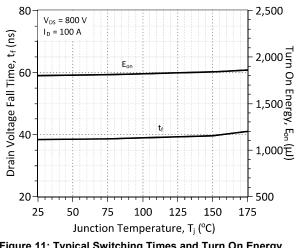
4.0 4.0 $25 \circ C, I_D/I_G = 40$ $75 \circ C, I_D/I_G = 40$ $125 \circ C, I_D/I_G = 30$ 3.5 $175 \circ C, I_D/I_G = 30$ 3.03.0

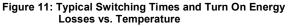
Figure 7: Typical Gate – Source Saturation Voltage











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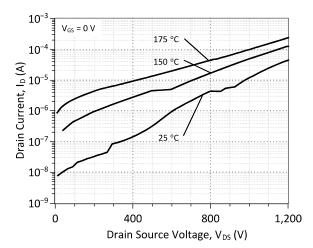


Figure 8: Typical Blocking Characteristics

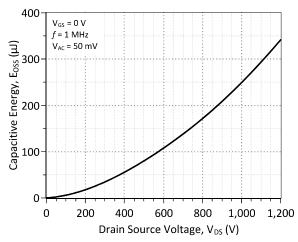


Figure 10: Energy Stored in Output Capacitance

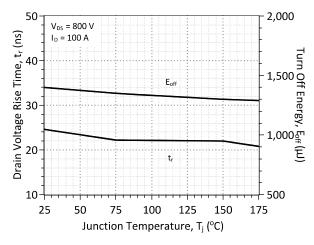


Figure 12: Typical Switching Times and Turn Off Energy Losses vs. Temperature

B: Dynamic Characte

80 2,500 V_{DS} = 800 V T = 25 °C Drain Voltage Fall Time, t_f (ns) 2,000 In Energy, Eon (60 Eon 40 te 20 1,000 € n 500 60 80 100 120 Drain Current, I_D (A)

Figure 13: Typical Switching Times and Turn On Energy Losses vs. Drain Current

C: Current and Power Derating

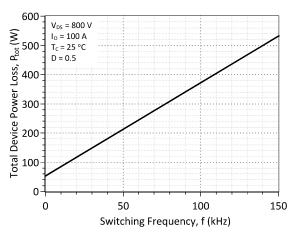


Figure 15: Typical Hard Switched Device Power Loss vs. Switching Frequency²

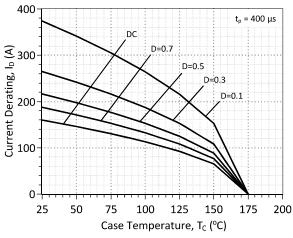


Figure 17: Drain Current Derating vs. Temperature

GA100SICP12-227

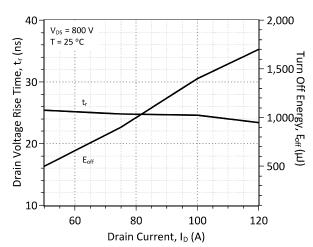
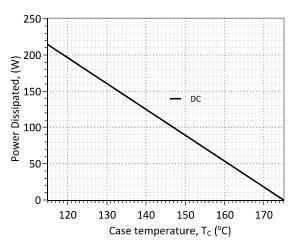
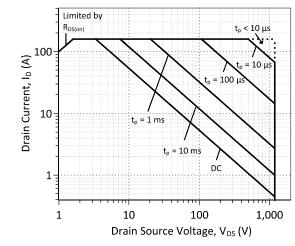
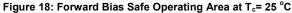


Figure 14: Typical Switching Times and Turn Off Energy Losses vs. Drain Current









² – Representative values based on device conduction and switching loss. Actual losses will depend on gate drive conditions, device load, and circuit topology.

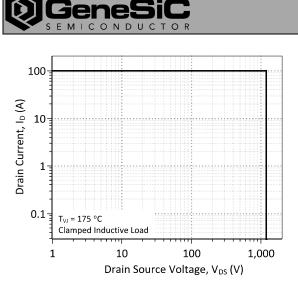


Figure 19: Turn-Off Safe Operating Area

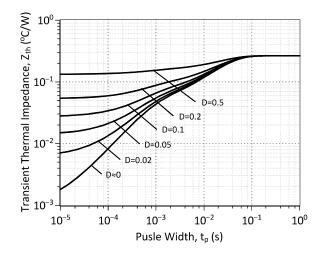


Figure 21: FWD Transient Thermal Impedance

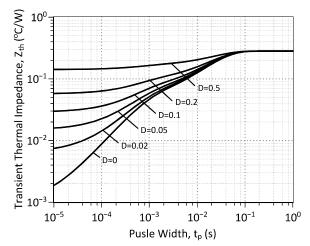


Figure 20: SJT Transient Thermal Impedance

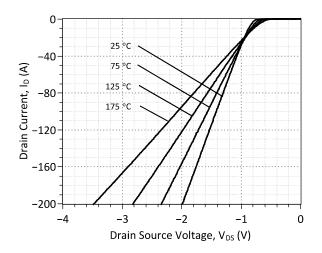


Figure 22: Typical FWD Forward Characteristics



Section V: Driving the GA100SICP12-227

Drive Topology	Gate Drive Power Consumption	Switching Frequency	Application Emphasis	Availability
TTL Logic	High	Low	Wide Temperature Range	Coming Soon
Constant Current	Medium	Medium	Wide Temperature Range	Coming Soon
High Speed – Boost Capacitor	Medium	High	Fast Switching	Production
High Speed – Boost Inductor	Low	High	Ultra Fast Switching	Coming Soon
Proportional	Lowest	High	Wide Drain Current Range	Coming Soon
Pulsed Power	Medium	N/A	Pulse Power	Coming Soon

A: Static TTL Logic Driving

The GA100SICP12-227 may be driven with direct (5 V) TTL logic and current amplification. The amplified current level of the supply must meet or exceed the steady state gate current ($I_{G,steady}$) required to operate the GA100SICP12-227. Minimum $I_{G,steady}$ is dependent on the anticipated drain current I_D through the SJT and the DC current gain h_{FE} , it may be calculated from the following equation. An accurate value of the h_{FE} may be read from Figure 4. An optional resistor R_G may be used in series with the gate pin to trim $I_{G,steady}$, also an optional capacitor C_G may be added in parallel with R_G to facilitate faster SJT switching if desired, further details on these options are given in the following section.

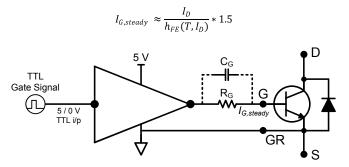


Figure 23: TTL Gate Drive Schematic

B: High Speed Driving

The SJT is a current controlled transistor which requires a positive gate current for turn-on and to remain in on-state. An idealized gate current waveform for ultra-fast switching of the SJT while maintaining low gate drive losses is shown in Figure 24, it features a positive current peak during turn-on, a negative current peak during turn-off, and continuous gate current during on-state.

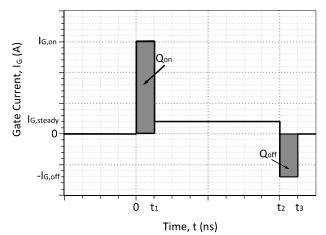


Figure 24: An idealized gate current waveform for fast switching of an SJT.

An SJT is rapidly switched from its blocking state to on-state when the necessary gate charge, Q_{G} , for turn-on is supplied by a burst of high gate current, $I_{G,on}$, until the SJT gate-source capacitance, C_{GS} , and gate-drain capacitance, C_{GD} , are fully charged.

$$Q_{on} = I_{G,on} * t_1$$
$$Q_{on} \ge Q_{gs} + Q_{gd}$$



Ideally, $I_{G,on}$ should terminate when the drain voltage falls to its on-state value in order to avoid unnecessary drive losses during the steady onstate. In practice, the rise time of the $I_{G,on}$ pulse is affected by the parasitic inductances, L_{par} in the device package and drive circuit. A voltage developed across the parasitic inductance in the source path, L_s , can de-bias the gate-source junction, when high drain currents begin to flow through the device. The voltage applied to the gate pin should be maintained high enough, above the V_{GS} ,sat (see Figure 7) level to counter these effects.

A high negative peak current, $-I_{G,off}$ is recommended at the start of the turn-off transition, in order to rapidly sweep out the injected carriers from the gate, and achieve rapid turn-off. Turn off can be achieved with $V_{GS} = 0$ V, however a negative gate voltage V_{GS} may be used in order to speed up the turn-off transition.

Gate Return Pin

The optional gate return (GR) pin allows for a reduction of source path inductive and resistive coupling in the gate driver connection to the GA100SICP12-227. Drain currents through the source pin during transient and steady state operation induce an undesirable source voltage in all power transistors due to unavoidable source pin inductance and resistance. This voltage can negatively affect gate driving performance, however the gate return pin allows for decoupling from these source current path effects which results in faster switching and higher efficiency gate driving.

B:1: High Speed, Low Loss Drive with Boost Capacitor, GA15IDDJT22-FR4

The GA100SICP12-227 may be driven using a High Speed, Low Loss Drive with Boost Capacitor topology in which multiple voltage levels, a gate resistor, and a gate capacitor are used to provide fast switching current peaks at turn-on and turn-off and a continuous gate current while in on-state. An evaluation gate drive board (GA15IDDJT22-FR4) utilizing this topology is commercially available low-side driving, its datasheet provides additional details.

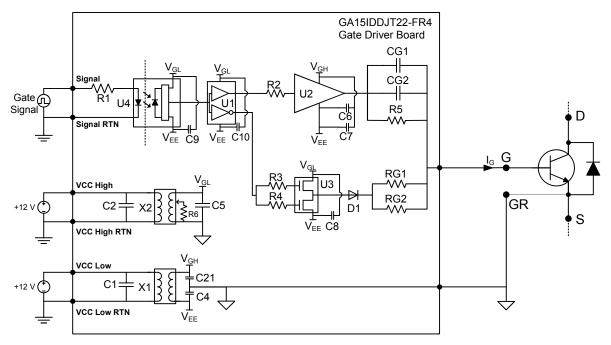


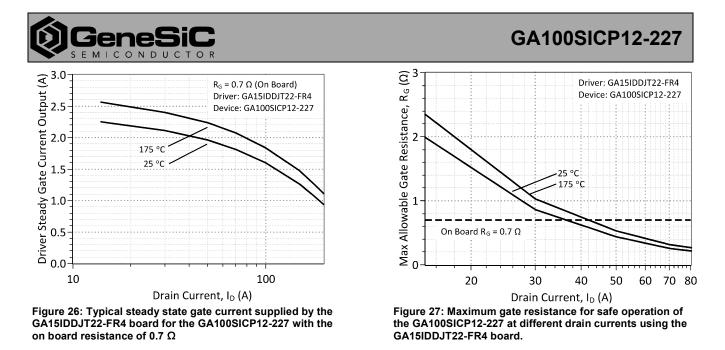
Figure 25: Topology of the GA15IDDJT22-FR4 Two Voltage Source gate driver.

The GA15IDDJT22-FR4 evaluation board comes equipped with two on board gate drive resistors (RG1, RG2) pre-installed for an effective gate resistance³ of RG = 0.7 Ω . It may be necessary for the user to reduce RG1 and/or RG2 under high drain current conditions for safe operation of the GA100SICP12-227. The steady state current supplied to the gate pin of the GA100SICP12-227 with on-board RG = 0.7 Ω , is shown in Figure 26. The maximum allowable safe value of RG for the user's required drain current can be read from Figure 27.

For the GA100SICP12-227, R_g must be reduced or shorted for $I_D \ge \sim 40$ A for safe operation with the GA15IDDJT22-FR4.

For operation at $I_D \ge -40$ A, R_G may be calculated from the following equation, which contains the DC current gain h_{FE} and the gate-source saturation voltage $V_{GS,sat}$ (Figure 7).

$$R_{G,max} = \frac{(4.7V - V_{GS,sat}) * h_{FE}(T, I_D)}{I_D * 1.5} - 0.1\Omega$$



B:2: High Speed, Low Loss Drive with Boost Inductor

A High Speed, Low-Loss Driver with Boost Inductor is also capable of driving the GA100SICP12-227 at high-speed. It utilizes a gate drive inductor instead of a capacitor to provide the high-current gate current pulses $I_{G,on}$ and $I_{G,off}$. During operation, inductor L is charged to a specified $I_{G,on}$ current value then made to discharge I_L into the SJT gate pin using logic control of S₁, S₂, S₃, and S₄, as shown in Figure 28. After turn on, while the device remains on the necessary steady state gate current $I_{G,steady}$ is supplied from source V_{CC} through R_G. Please refer to the article "A current-source concept for fast and efficient driving of silicon carbide transistors" by Dr. Jacek Rąbkowski for additional information on this driving topology.⁴

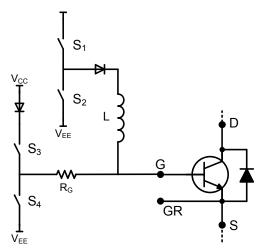


Figure 28: Simplified Inductive Pulsed Drive Topology

⁴ – Archives of Electrical Engineering. Volume 62, Issue 2, Pages 333–343, ISSN (Print) 0004-0746, DOI: 10.2478/aee-2013-0026, June 2013

 $^{^{3}}$ – R_G = (1/RG1 +1/RG2)⁻¹. Driver is pre-installed with RG1 = 2.2 Ω , RG2 = 1.0 Ω



C: Proportional Gate Current Driving

For applications in which the GA100SICP12-227 will operate over a wide range of drain current conditions, it may be beneficial to drive the device using a proportional gate drive topology to optimize gate drive power consumption. A proportional gate driver relies on instantaneous drain current I_D feedback to vary the steady state gate current $I_{G,steady}$ supplied to the GA100SICP2-227

C:1: Voltage Controlled Proportional Driver

The voltage controlled proportional driver relies on a gate drive IC to detect the GA100SICP12-227 drain-source voltage V_{DS} during on-state to sense I_D . The gate drive IC will then increase or decrease $I_{G,steady}$ in response to I_D . This allows $I_{G,steady}$, and thus the gate drive power consumption, to be reduced while I_D is relatively low or for $I_{G,steady}$ to increase when is I_D higher. A high voltage diode connected between the drain and sense protects the IC from high-voltage when the driver and GA100SICP12-227 are in off-state. A simplified version of this topology is shown in Figure 29, additional information will be available in the future at http://www.genesicsemi.com/commercial-sic/sic-junction-transistors/

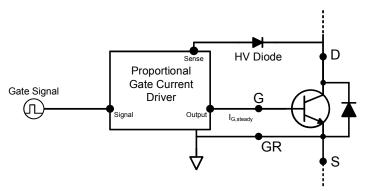


Figure 29: Simplified Voltage Controlled Proportional Driver

C:2: Current Controlled Proportional Driver

The current controlled proportional driver relies on a low-loss transformer in the drain or source path to provide feedback I_D of the GA100SICP12-227 during on-state to supply $I_{G,steady}$ into the device gate. $I_{G,steady}$ will then increase or decrease in response to I_D at a fixed forced current gain which is set be the turns ratio of the transformer, $h_{force} = I_D / I_G = N_2 / N_1$. GA100SICP12-227 is initially turned-on using a gate current pulse supplied into an RC drive circuit to allow I_D current to begin flowing. This topology allows $I_{G,steady}$, and thus the gate drive power consumption, to be reduced while I_D is relatively low or for $I_{G,steady}$ to increase when is I_D higher. A simplified version of this topology is shown in Figure 30, additional information will be available in the future at http://www.genesicsemi.com/commercial-sic/sic-junction-transistors/.

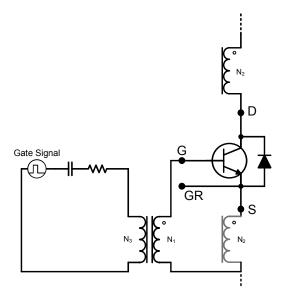
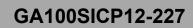


Figure 30: Simplified Current Controlled Proportional Driver

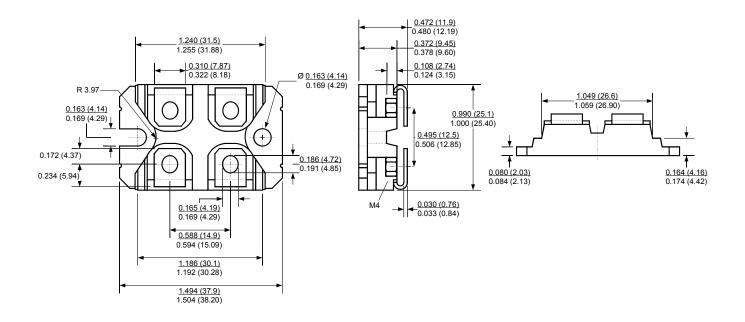


Section VI: Package Dimensions

GeneSiC semiconductor

SOT-227

PACKAGE OUTLINE



NOTE

1. CONTROLLED DIMENSION IS INCH. DIMENSION IN BRACKET IS MILLIMETER.

2. DIMENSIONS DO NOT INCLUDE END FLASH, MOLD FLASH, MATERIAL PROTRUSIONS

Revision History								
Date	Revision	Comments	Supersedes					
2015/12/07	1	Updated Electrical Characteristics						
2015/03/30	0	Initial release						

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GeneSiC

Section VII: SPICE Model Parameters

This is a secure document. Please copy this code from the SPICE model PDF file on our website (http://www.genesicsemi.com/images/products_sic/igbt_copack/GA100SICP12-227_SPICE.pdf) into LTSPICE (version 4) software for simulation of the GA100SICP12-227.

```
*
     MODEL OF GeneSiC Semiconductor Inc.
*
     $Revision: 2.0
                                  $
*
                 07-DEC-2015
                                  $
     $Date:
*
*
     GeneSiC Semiconductor Inc.
*
     43670 Trade Center Place Ste. 155
     Dulles, VA 20166
*
*
*
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*
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*
* These models are provided "AS IS, WHERE IS, AND WITH NO WARRANTY
* OF ANY KIND EITHER EXPRESSED OR IMPLIED, INCLUDING BUT NOT LIMITED
* TO ANY IMPLIED WARRANTIES OF MERCHANTABILITY AND FITNESS FOR A
* PARTICULAR PURPOSE."
*
 Models accurate up to 2 times rated drain current.
* Start of GA100SICP12-227 SPICE Model
.SUBCKT GA100SIPC12 DRAIN GATE SOURCE
QA1 DRAIN GATE SOURCE GA100SIPC12 Q
DA1 SOURCE DRAIN GA100SIPC12 D1
DA2 SOURCE DRAIN GA100SIPC12 D2
QB1 DRAIN GATE SOURCE GA100SIPC12 Q
DB1 SOURCE DRAIN GA100SIPC12 D1
DB2 SOURCE DRAIN GA100SIPC12 D2
.model GA100SIPC12 Q NPN
           9.833E-48
+ IS
                                        1.073E-26
                                                                     3.23
                             ISE
                                                         ΕG
+ BF
           89
                            BR
                                        0.55
                                                          IKF
                                                                     9000
+ NF
           1
                            ΝE
                                        2
                                                                     0.95
                                                          RB
           0.004
+ RE
                            RC
                                        0.0125
                                                                     2.398E-9
                                                         CJC
           2.8346
+ VJC
                            MJC
                                        0.4846
                                                         CJE
                                                                     6.026E-09
+ VJE
           3.1791
                            MJE
                                        0.5295
                                                         XTI
                                                                     3
+ XTB
           -1.5
                             TRC1
                                        9.0E-03
                                                         MFG
                                                               GeneSiC Semi
+ IRB
           0.005
                                        0.073
                             RBM
.MODEL GA100SIPC12 D1 D
          1.99E-16
                             RS
                                        0.015652965
                                                                     1
+ IS
                                                          Ν
                                                                     3
           1000
                                        1.2
+ IKF
                             ΕG
                                                          XTI
+ TRS1
           0.0042
                             TRS2
                                        1.3E-05
                                                          CJO
                                                                     3.86E-09
           1.362328465
+ VJ
                                        0.48198551
                                                          FC
                                                                     0.5
                            М
+ TT
           1.00E-10
                             IAVE
                                        50
.MODEL GA100SIPC12 D2 D
           1.54E-19
                             RS
                                        0.1
                                                                     3.941
+ IS
                                                         Ν
           3.23
                                        -0.004
                                                                     19
+ EG
                             TRS1
                                                          IKF
           0
+ XTI
                             FC
                                        0.5
                                                          TT
                                                                     Ω
.ENDS
```

* End of GA100SICP12-227 SPICE Model